

U.S. Department of Commerce, Patent and Trademark Office				Docket No. 8033064		Serial No. 10/000,001		
(PTO Form 1449 modified)								
LIST OF PATENTS AND PUBLICATIONS CITED BY APPLICANT				Applicant Wang et al.				
(Use several sheets if necessary)				COPY OF PAPERS COPY OF FILED ORIGINALLY FILED		Filing Date October 24, 2001	Group 2877	
		Examiner Unknown						
U.S. Patent Documents								
*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date If Appropriate	
PJC	1	5,999,261	12/7/99	Pressesky et al.	256	854	7/10/98	
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Foreign Patent Documents								
*Examiner Initial		Document Number	Date	Country	Class	Subclass	Translation	
							YES	NO
	14						<input type="checkbox"/>	<input type="checkbox"/>
	15						<input type="checkbox"/>	<input type="checkbox"/>
	16						<input type="checkbox"/>	<input type="checkbox"/>
OTHER ART								
*Examiner Initial		Including Author, Title, Date, Pertinent Pages, Etc.						
PJC	17	Chris L. Koliopoulos, "Simultaneous phase shift interferometer", Advanced Optical Manufacturing and Testing II, Proc. SPIE Vol. 1531, p. 119-127 (1991).						
PJC	18	Jianmin Wang and Ian Grant, "ESPI, Phase mapping, NDT the techniques applied to real-time, thermal loading", Appl. Opt. 34, 3620-3627						
	19							
Examiner <u>PATRICK CONNELL</u>				Date Considered <u>9/30/2003</u>				
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.								